

# NF3M20170K

1700V Silicon Carbide Power MOSFET 1700V G2 ( N Channel Enhancement )

## Features

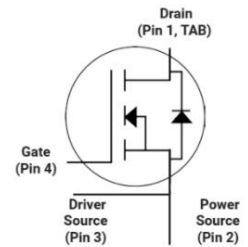
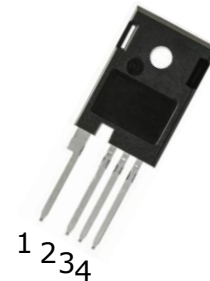
- High speed switching
- Very low switching losses
- High blocking voltage with low on-resistance
- Temperature independent turn-off switching losses
- Halogen free, RoHS compliant

## Benefits

- Cooling effort reduction
- Efficiency improvement
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency

## Applications

- EV motor drive
- PV string inverters
- Solar power optimizer
- Switch mode power supplies



TO-247-4L



Table 1 Key performance and package parameters

Type	V <sub>DS</sub>	I <sub>DS</sub> (T <sub>C</sub> = 25°C, R <sub>th(j-c,max)</sub> )	R <sub>DS(ON), typ</sub> (V <sub>GS</sub> = 18V, I <sub>D</sub> = 75A, T <sub>J</sub> = 25°C)	T <sub>j,max</sub>	Marking	Package
NF3M20170K	1700V	90A	20mΩ	175°C	NF3M20170K	TO247-4L

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### 1、Maximum ratings

Table 2 Maximum rating ( $T_c = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
$V_{DS,max}$	Drain source voltage	1700	V	$V_{GS} = 0\text{V}$ , $I_D = 100\ \mu\text{A}$	
$V_{GS,max}$	Gate source voltage	-8 /+22	V	Absolute maximum values	Note1
$V_{GSop}$	Gate source voltage	-4 /+18	V	Recommended operational values	
$I_D$	Continuous drain current	90	A	$V_{GS} = 18\text{V}$ , $T_c = 25^\circ\text{C}$	Fig.19
		64		$V_{GS} = 18\text{V}$ , $T_c = 100^\circ\text{C}$	
$I_{D(pulse)}$	Pulsed drain current	180	A	Pulse width $t_p$ limited by $T_{j,max}$	Fig.22
$P_D$	Power dissipation	356	W	$T_c = 25^\circ\text{C}$ , $T_j = 175^\circ\text{C}$	Fig.20
$T_J, T_{stg}$	Operating Junction and storage temperature	-55 to +175	$^\circ\text{C}$		
$T_L$	Soldering temperature	260	$^\circ\text{C}$	1.6mm (0.063") from case for 10s	
$T_M$	Mounting torque	1	Nm	M3 or 6-32 screw	
		8.8	lbf-in		

Note 1: when using MOSFET Body Diode  $V_{GS,max} = -4 / +22\text{V}$

### 2、Thermal characteristics

Table 3 Thermal characteristics<sup>1</sup>

Symbol	Parameter	Value	Unit	Test Conditions	Note
$R_{th(j-c)}$	Thermal resistance from junction to case	0.26	$^\circ\text{C}/\text{W}$	-	Fig.21

<sup>1</sup> Not subject to production test. Parameter verified by design/characterization.

### 3、Electrical characteristics

#### 3.1 Static characteristics

**Table 4** Static characteristics (Tc = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-source breakdown voltage	1700	-	-	V	$V_{GS} = 0V, I_D = 100\mu A$	
$V_{GS(th)}$	Gate threshold voltage	2.3	3.3	4	V	$V_{DS} = V_{GS}, I_D = 30mA$	Fig.11
		-	2.5	-	V	$V_{DS} = V_{GS}, I_D = 30mA,$ $T_J = 175^\circ C$	
$I_{DSS}$	Zero gate voltage drain current	-	1	10	$\mu A$	$V_{DS} = 1700V, V_{GS} = 0V$	
$I_{GSS}$	Gate source leakage current	-	-	100	nA	$V_{GS} = 18V, V_{DS} = 0V$	
$R_{DS(on)}$	Current drain-source on-state resistance	-	24	36	m $\Omega$	$V_{GS} = 15V, I_D = 75A$	Fig.4,5,6
		-	46	-		$V_{GS} = 15V, I_D = 75A,$ $T_J = 175^\circ C$	
		-	20	30		$V_{GS} = 18V, I_D = 75A$	
		-	44	-		$V_{GS} = 18V, I_D = 75A,$ $T_J = 175^\circ C$	
gfs	Transconductance	-	51	-	S	$V_{DS} = 20V, I_D = 75A$	Fig.7
		-	41	-		$V_{DS} = 20V, I_D = 75A,$ $T_J = 175^\circ C$	
$R_{g,int}$	Internal gate resistance	-	2.7	-	$\Omega$	$V_{AC} = 25mV, f = 1MHz,$ open drain	

#### 3.2 Dynamic characteristics

**Table 5** Dynamic characteristics (Tc = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$C_{iss}$	Input capacitance	-	5265	-	pF	$V_{DS} = 1400V, V_{GS} = 0V,$ $T_J = 25^\circ C, V_{AC} = 25mV,$ $f = 100KHz$	Fig.17,18
$C_{oss}$	Output capacitance	-	188	-			
$C_{rss}$	Reverse capacitance	-	7.5	-			
$E_{oss}$	Coss stored energy	-	189	-	$\mu J$		Fig.16

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$Q_{gs}$	Gate source charge	-	75	-	nC	$V_{DS} = 1200V,$ $V_{GS} = -4/+18V,$ $I_D = 75A$	Fig.12
$Q_{gd}$	Gate drain charge	-	56	-			
$Q_g$	Gate charge	-	209	-			

### 3.3 Switching characteristics

**Table 6 Dynamic characteristics**( $T_c = 25^\circ C$  unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$E_{on}$	Turn on switching energy	-	2229	-	$\mu J$	$V_{DS} = 1200V, V_{GS} = -4/+18V,$ $I_D = 75A, R_g = 2.5\Omega,$ $L = 16.7\mu H$	Fig.26
$E_{off}$	Turn off switching energy	-	501	-			
$t_{d(on)}$	Turn on delay time	-	39	-	ns	$V_{DS} = 1200V, V_{GS} = -4/+18V,$ $I_D = 75A, R_g = 2.5\Omega,$ $L = 16.7\mu H$	Fig.27
$t_r$	Rise time	-	21	-			
$t_{d(off)}$	Turn off delay time	-	49	-			
$t_f$	Fall time	-	14	-			

**Table 7 Body diode characteristics**

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{SD}$	Diode forward voltage	-	4.0	-	V	$V_{GS} = -4V, I_{SD} = 50A$	Fig.8,9, 10
		-	3.5	-	V	$V_{GS} = -4V, I_{SD} = 50A,$ $T_j = 175^\circ C$	
$I_S$	Continuous diode forward current	-	89	-	A	$V_{GS} = -4V, T_c = 25^\circ C$	
$t_{rr}$	Reverse recovery time	-	28	-	ns	$V_R = 1200V, V_{GS} = -4V,$ $I_D = 75A,$ $di/dt = 6770A/\mu s,$ $T_j = 175^\circ C$	
$Q_{rr}$	Reverse recovery charge	-	1066	-	nC		
$I_{rrm}$	Peak reverse recovery current	-	65	-	A		

Note : When using SiC Body Diode the maximum recommended  $V_{GS} = -4V$

### 4、Electrical characteristic diagrams

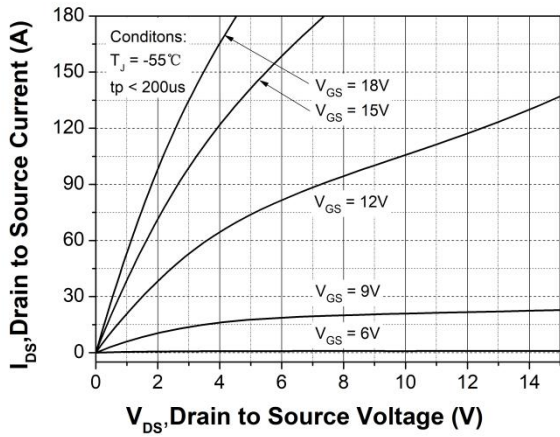


Figure 1. Output characteristics  $T_J = -55\text{ }^\circ\text{C}$

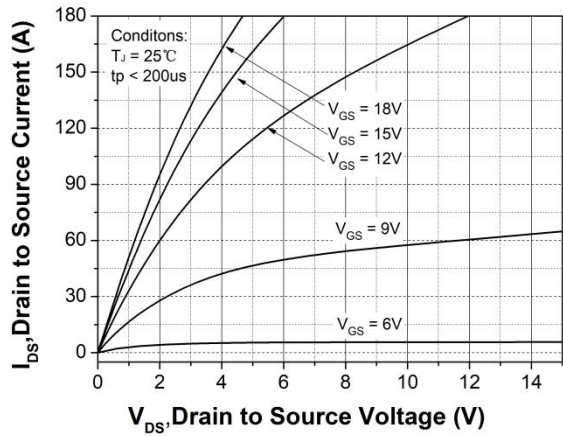


Figure 2. Output characteristics  $T_J = 25\text{ }^\circ\text{C}$

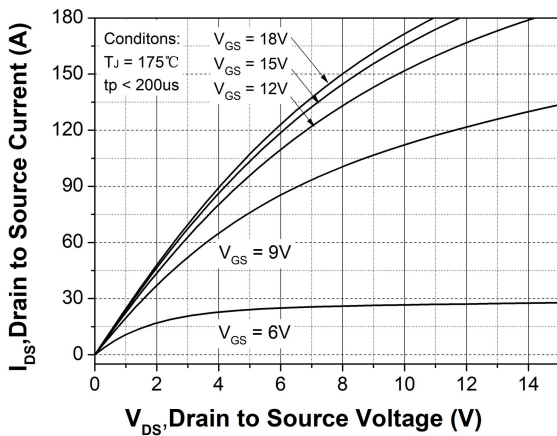


Figure 3. Output characteristics  $T_J = 175\text{ }^\circ\text{C}$

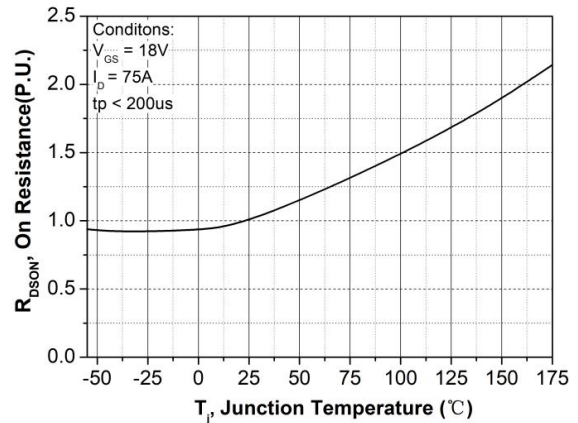


Figure 4. Normalized on-resistance vs. temperature

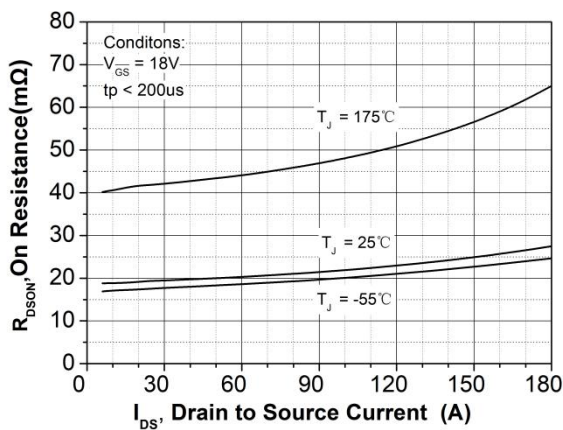


Figure 5. On-resistance vs. drain current for various temperatures

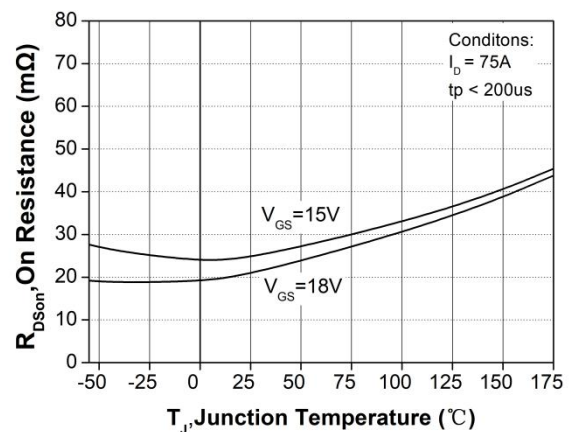


Figure 6. On-resistance vs. temperature for various gate voltage

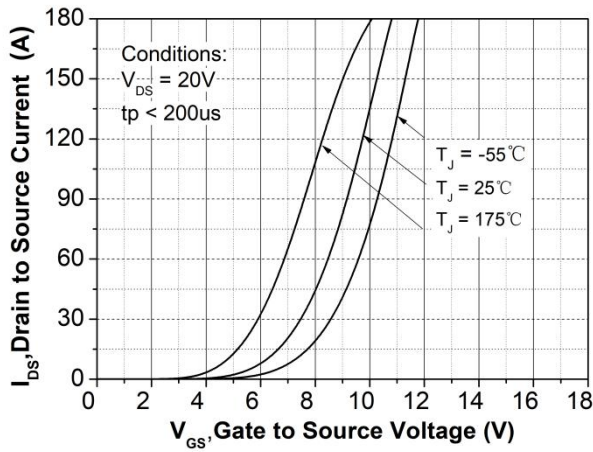


Figure 7. Transfer characteristic for various junction temperatures

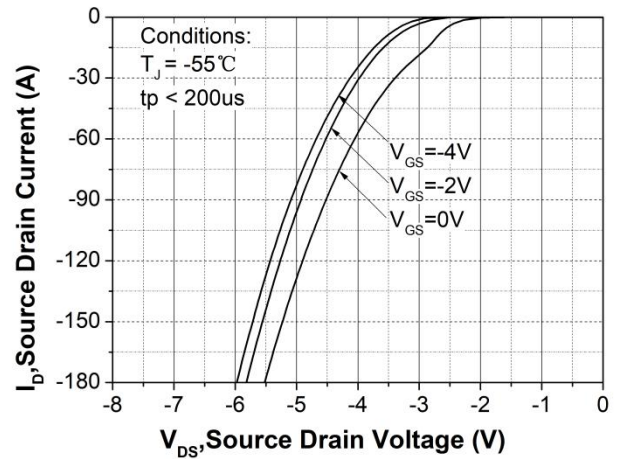


Figure 8. Body diode characteristic at  $T_J = -55^\circ\text{C}$

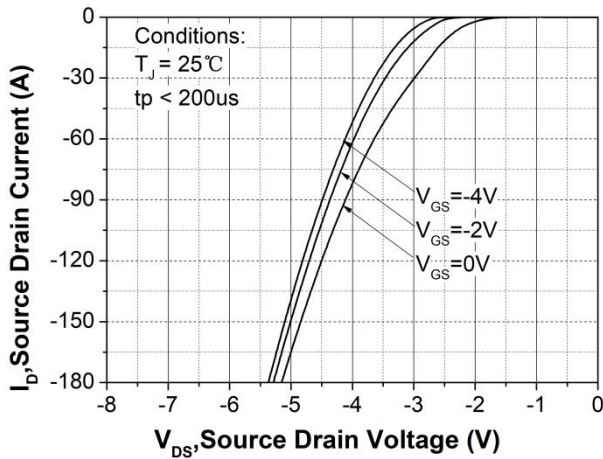


Figure 9. Body diode characteristic at  $T_J = 25^\circ\text{C}$

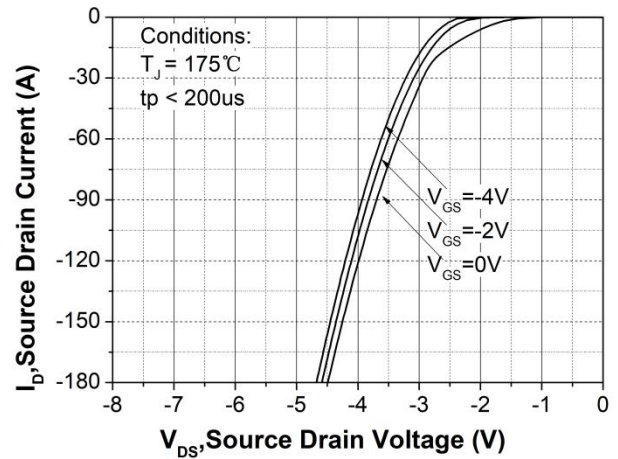


Figure 10. Body diode characteristic at  $T_J = 175^\circ\text{C}$

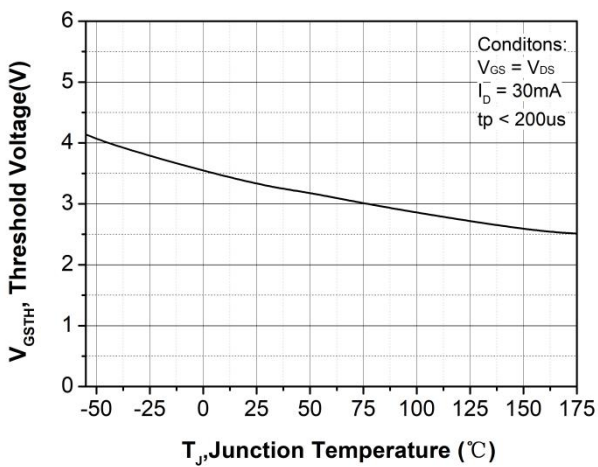


Figure 11. Threshold voltage vs. temperature

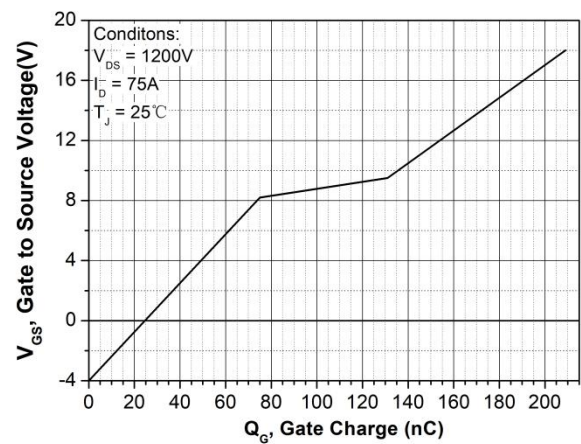


Figure 12. Gate charge characteristic

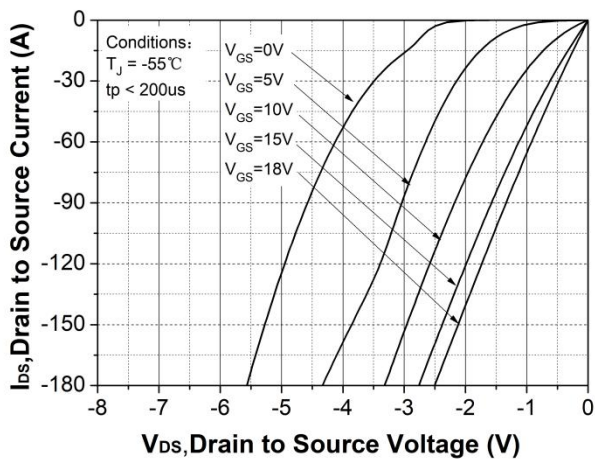


Figure 13. 3rd quadrant characteristic at  $T_J = -55\text{ }^\circ\text{C}$

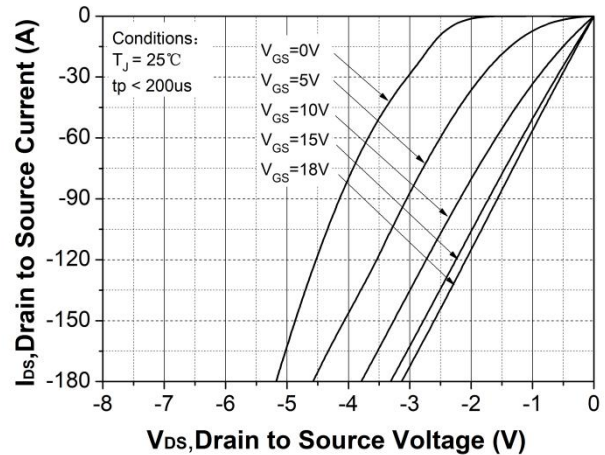


Figure 14. 3rd quadrant characteristic at  $T_J = 25\text{ }^\circ\text{C}$

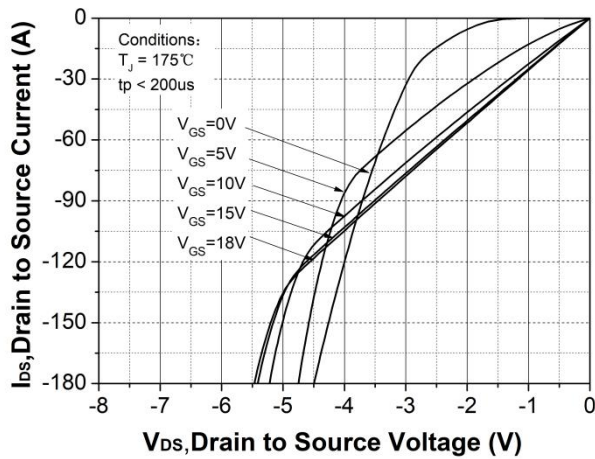


Figure 15. 3rd quadrant characteristic at  $T_J = 175\text{ }^\circ\text{C}$

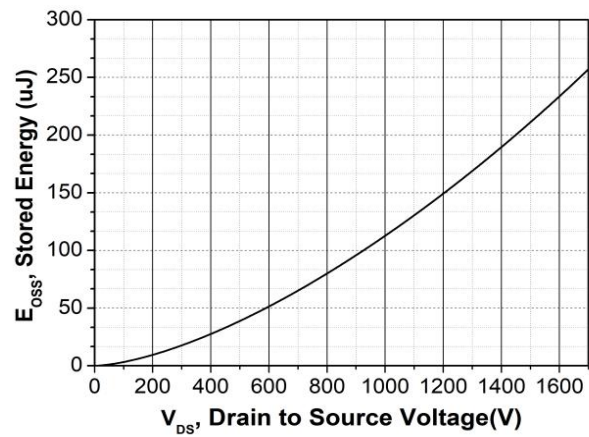


Figure 16. Output capacitor stored energy

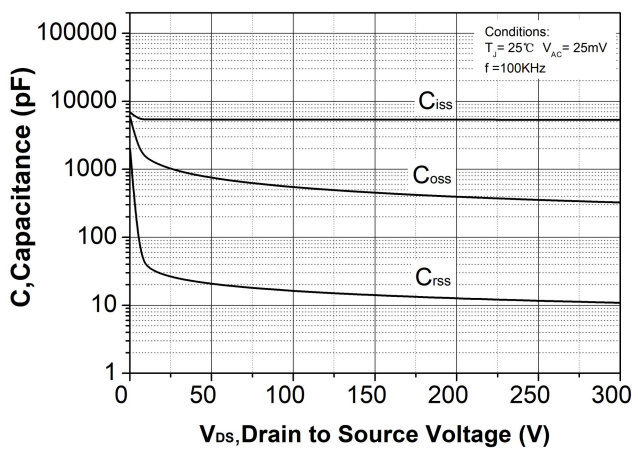


Figure 17. Capacitances vs. drain-source voltage (0 - 300V)

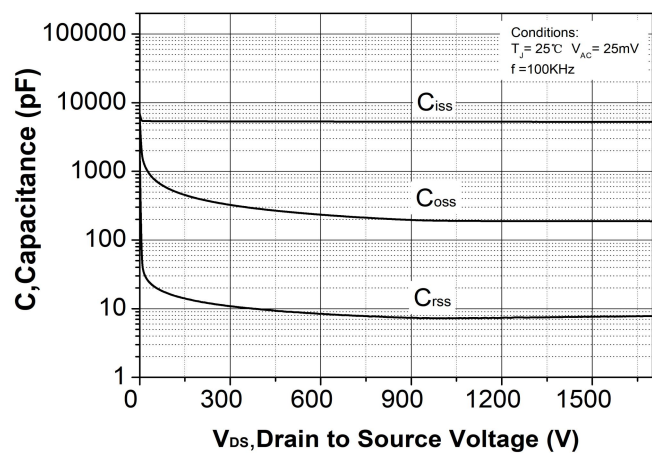


Figure 18. Capacitances vs. drain-source voltage (0 - 1700V)



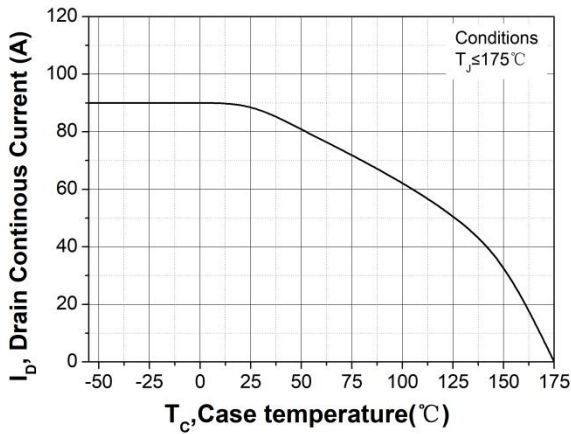


Figure 19. Continuous drain current derating vs. case temperature

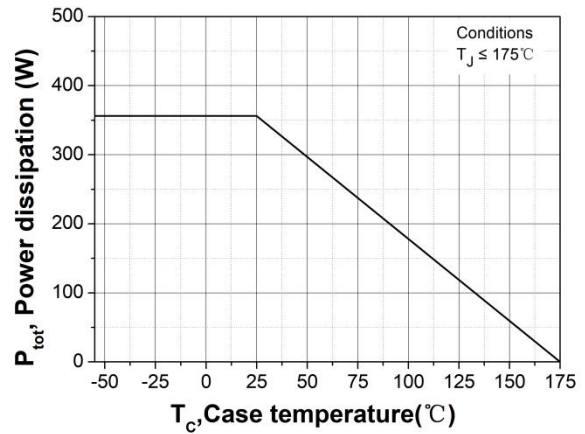


Figure 20. Maximum power dissipation derating vs. case temperature

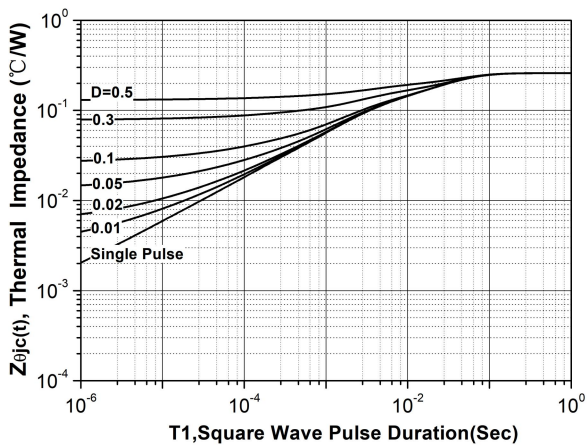


Figure 21. Transient thermal impedance (junction - case)

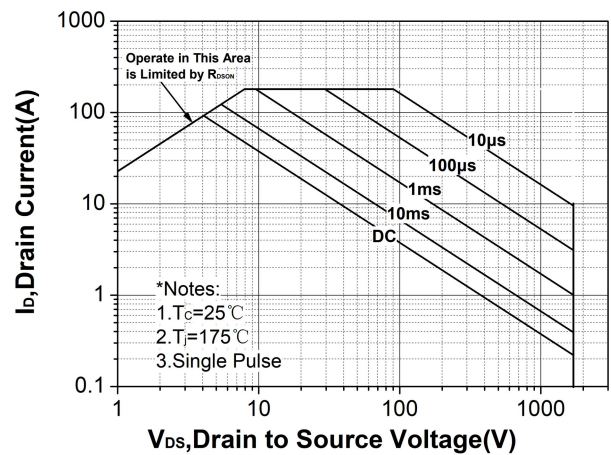


Figure 22. Safe operating area

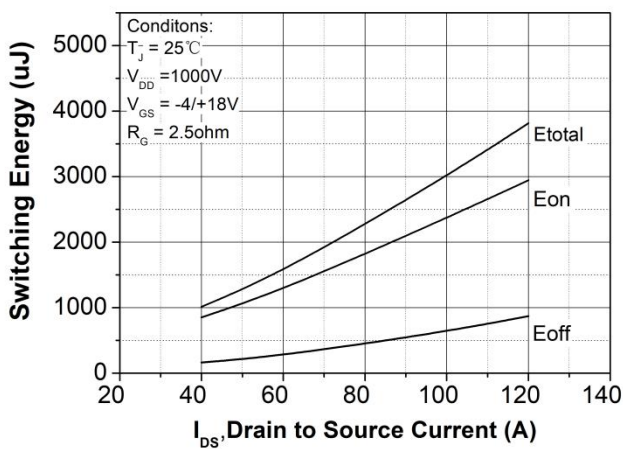


Figure 23. Clamped Inductive switching energy vs. drain current ( $V_{DD} = 1000V$ )

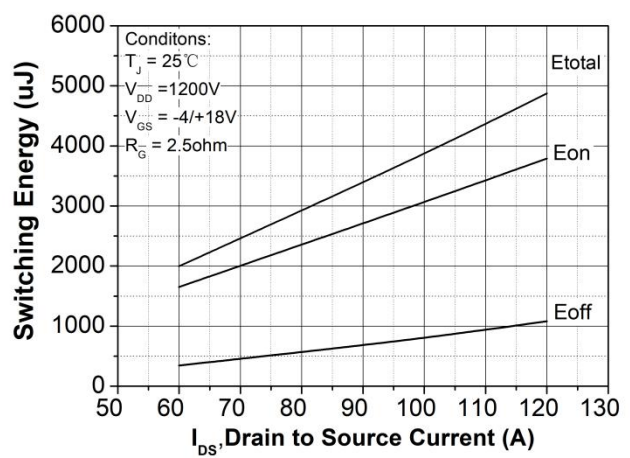


Figure 24. Clamped inductive switching energy vs. drain current ( $V_{DD} = 1200V$ )

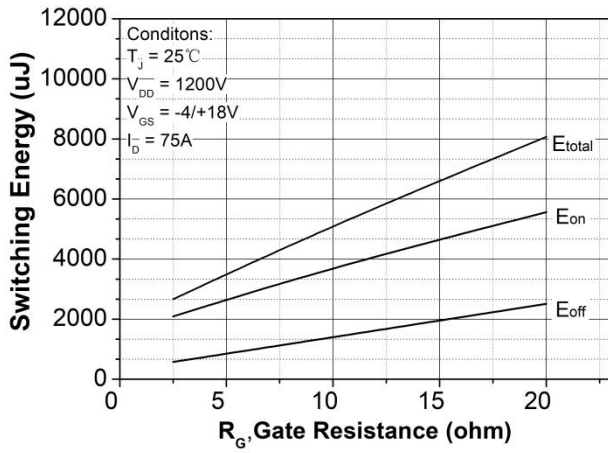


Figure 25. Clamped inductive switching energy vs.  $R_G(ext)$

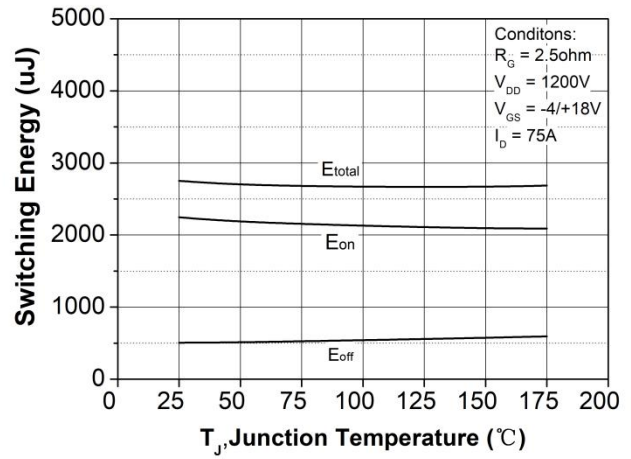


Figure 26. Clamped inductive switching energy vs. temperature

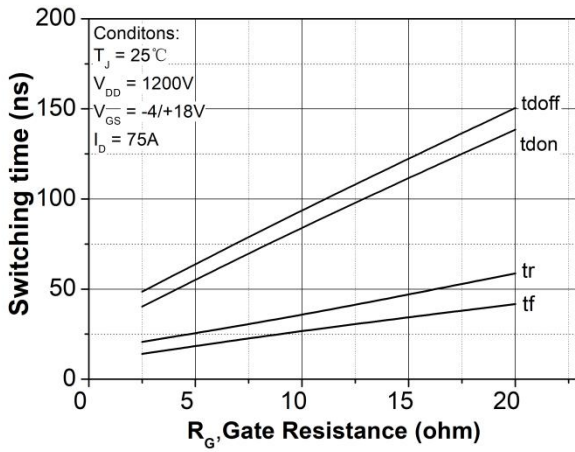
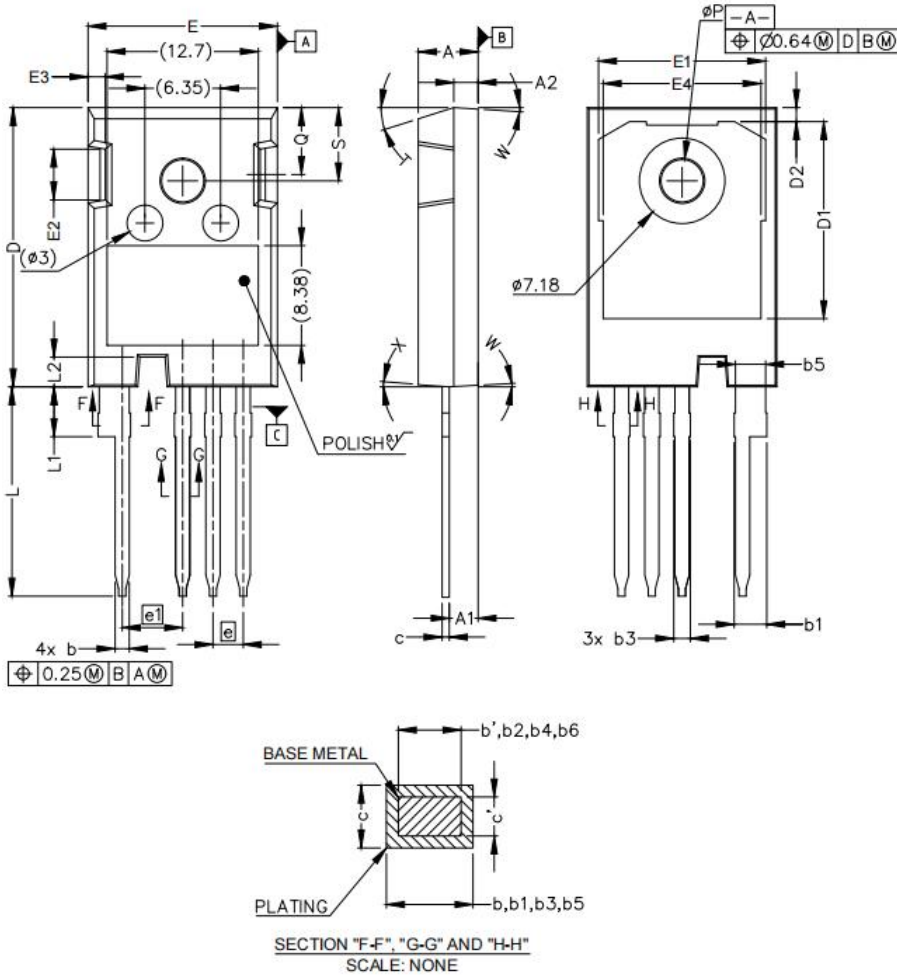


Figure 27. Switching times vs.  $R_G(ext)$

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## 5、 Package drawing ( TO-247-4L )



SYMBOL	MILLIMETERS	
	MIN	MAX
A	4.83	5.21
A1	2.29	2.54
A2	1.91	2.16
b'	1.07	1.28
b	1.07	1.33
b1	2.39	2.94
b2	2.39	2.84
b3	1.07	1.60
b4	1.07	1.50
b5	2.39	2.69
b6	2.39	2.64
c'	0.55	0.65
c	0.55	0.68
D	23.30	23.60
D1	16.25	17.65
D2	0.95	1.25
E	15.75	16.13
E1	13.10	14.15
E2	3.68	5.10
E3	1.00	1.90
E4	12.38	13.43
e	2.54 BSC	
e1	5.08 BSC	
N	4	
L	17.31	17.82
L1	3.97	4.37
L2	2.35	2.65
øP	3.51	3.65
Q	5.49	6.00
S	6.04	6.30
T	17.5° REF.	
W	3.5° REF.	
X	4° REF.	

### 6、 Test conditions

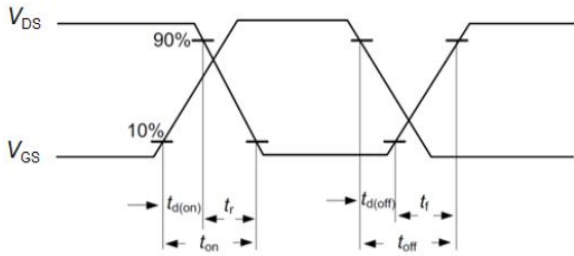


Figure A. Definition of switching times

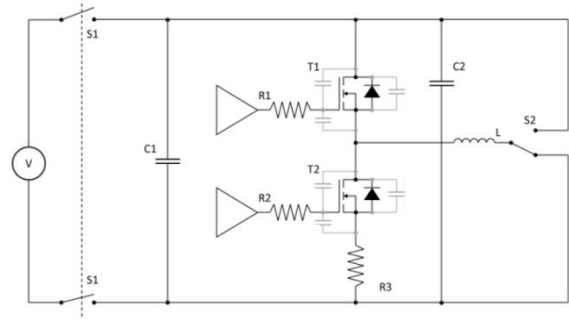


Figure B. Dynamic test circuit

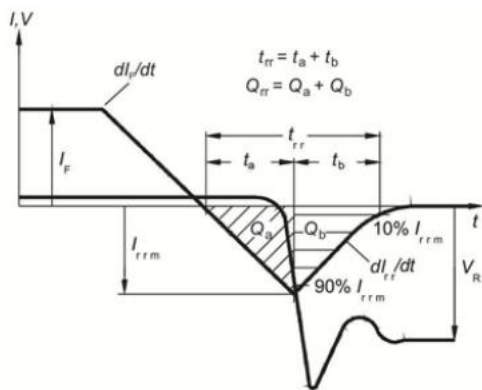


Figure C. Definition of diode switching characteristics

Figure C. Definition of body diode switching characteristics

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## Revision history

Document version	Date of release	Description of changes
V01_00	2024-03-01	--